

Fabrication of quasi-Gaussian-shaped nanoholes by MBE local droplet etching

X. Zhang^{1*}, R. Keil¹, Y. Chen¹, Y. Li¹, F. Ding^{1,2} and O. G. Schmidt^{1,3}

¹ Institute for Integrative Nanoscience, IFW Dresden, Helmholtzstr. 20, 01069 Dresden, Germany

² Institut für Festkörperphysik, Leibniz Universität Hannover, Appelstr. 2, 30167 Hannover, Germany

³ Material Systems for Nanoelectronics, Technische Universität Chemnitz, Reichenhainer Str.70, 09107, Chemnitz, Germany

Nanoholes are of significant importance in the research of current nanotechnologies. For one thing, they are frequently used as the growth templates for quantum dots, nanowires, nanopillars and many other advanced nanoarchitectures [1]; for another, nanohole is an ideal platform for the research of photonic confinement in nanophotonics, and polariton trapping in the condensed-matter physics [2].

The fabrications of nanoholes are generally achieved by lithographic, dry/wet etching, and focused ion beam (FIB) milling etc. Here we present the fabrication of quasi-Gaussian-shaped nanoholes by in-situ MBE local droplet etching method on the surface of III-V semiconductor wafers. The unique advantage of this technique is the compatibility with subsequent MBE growths.

The process starts with the generation of metallic droplets on the AlGaAs surface in Volmer-Weber growth mode by depositing several monolayer of Al at a temperature between 630 °C and 700 °C without As flux, subsequently an additional annealing step without As flux is followed to transfer Al metal droplet into nanoholes with the help of atomic diffusion [3].

The Atomic Force Microscopy (AFM) measurement shows that the hole density is around $2.3 \times 10^7 \text{ cm}^{-2}$ and hole depth is around 30 nm at the etching temperature of 630 °C, as shown in Fig 1. These holes have a depth of 30 nm and were surrounded by smooth sidewalls, In addition, these nanoholes have Gaussian-shaped profiles, as depicted in Fig 1(b-c). Highly efficient photon confinement can be achieved [4], if such holes could be introduced into a well-designed microcavity.

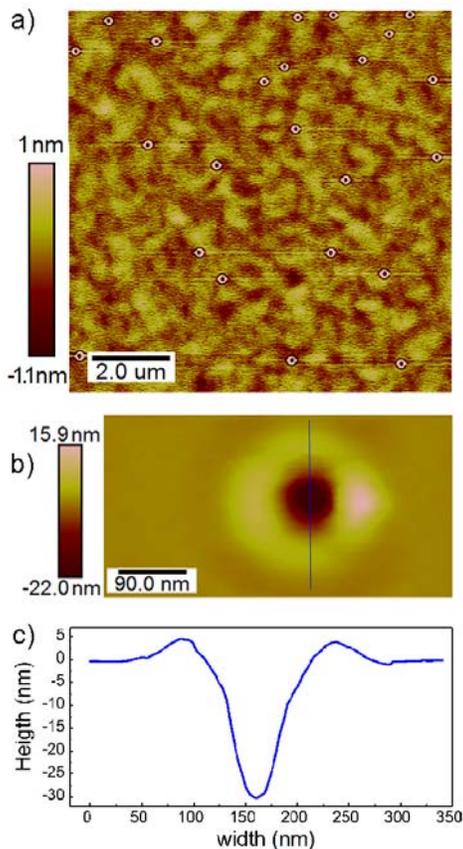


Fig. 1: The AFM images of the surface morphology of the MBE local droplet etched sample. a) the AFM image of a $10 \times 10 \text{ um}^2$ area; b) the AFM image a single nanohole; c) the depth profile of the single hole measured in Fig. 1(b).

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*Contact: x.zhang@ifw-dresden.de